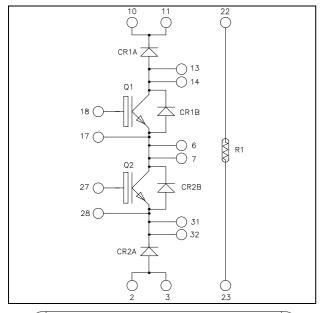
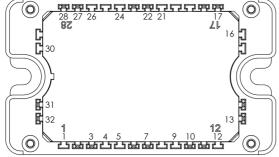


## Boost buck chopper Trench + Field Stop IGBT3 Power Module

 $V_{CES} = 600V$  $I_C = 100A*$  @ Tc = 80°C





All multiple inputs and outputs must be shorted together Example: 10/11; 13/14; 6/7...

#### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Very low stray inductance
- Kelvin emitter for easy drive
- Internal thermistor for temperature monitoring
- High level of integration

#### Benefits

- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- **RoHS Compliant**

All ratings @  $T_i = 25^{\circ}C$  unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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### Absolute maximum ratings (Per IGBT)

Symbol	Parameter		Max ratings	Unit
$V_{CES}$	Collector - Emitter Breakdown Voltage		600	V
Ţ	Continuous Collector Current	$T_C = 25^{\circ}C$	150*	
$I_{\rm C}$		$T_C = 80$ °C	100*	Α
$I_{CM}$	Pulsed Collector Current	$T_C = 25^{\circ}C$	200	
$V_{GE}$	Gate – Emitter Voltage		±20	V
$P_{D}$	Maximum Power Dissipation	$T_C = 25^{\circ}C$	340	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 150$ °C	200A @ 550V	

<sup>\*</sup> Specification of device but output current must be limited due to size of output pins.

### Electrical Characteristics (Per IGBT)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$				250	μA
V	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25$ °C		1.5	1.9	V
$V_{CE(sat)}$		$I_{\rm C} = 100 {\rm A}$ $T_{\rm j} = 150 {\rm ^{\circ}C}$		1.7		v	
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1.5 \text{ mA}$		5.0	5.8	6.5	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

### **Dynamic Characteristics** (Per IGBT)

Symbol	Characteristic	Test Conditions		Typ	Max	Unit
$C_{ies}$	Input Capacitance	$V_{GE} = 0V$		6100		
$C_{oes}$	Output Capacitance	$V_{CE} = 25V$		390		pF
$C_{res}$	Reverse Transfer Capacitance	f = 1MHz		190		
$Q_{G}$	Gate charge	$V_{GE} = \pm 15V ; V_{CE} = 300V$ $I_{C} = 100A$		1.1		μC
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C)		115		
$T_{\rm r}$	Rise Time	$V_{GE} = \pm 15V$		45		ns
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 300V$ $I_C = 100A$		225		
$T_{\mathrm{f}}$	Fall Time	$R_G = 3.3\Omega$		55		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C	()	130		ns
$T_{\rm r}$	Rise Time	$V_{GE} = \pm 15V$		50		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 300V$ $I_C = 100A$		300		
$T_{\mathrm{f}}$	Fall Time	$R_G = 3.3\Omega$		70		
Е	Turn on Engrav	$V_{GE} = \pm 15V$ $T_j = 25^{\circ}C$		0.4		mJ
Eon	Turn on Energy	$V_{\text{Bus}} = 300\text{V}$ $T_{\text{j}} = 150^{\circ}\text{C}$		0.875		IIIJ
Е	Turn off Energy	$I_C = 100A$ $T_j = 25^{\circ}C$		2.5		m I
$E_{off}$	$E_{\text{off}}$ Turn off Energy $R_{\text{G}} = 3.3\Omega$	$R_G = 3.3\Omega \qquad T_j = 150^{\circ}C$		3.5		mJ
$I_{sc}$	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 360V$ $t_p \le 6\mu s$ ; $T_i = 150^{\circ}C$		500		A



Reverse diode ratings and characteristics (Per diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			600			V
$I_{RM}$	Maximum Reverse Leakage Current	V <sub>R</sub> =600V	$T_{\rm j} = 25^{\circ}{\rm C}$			150	μΑ
$I_{\mathrm{F}}$	DC Forward Current		$T_{j} = 150^{\circ}C$ $Tc = 80^{\circ}C$		100	400	A
W	Diada Famyand Valtaga	$I_F = 100A$ $V_{GE} = 0V$	$T_i = 25^{\circ}C$		1.6	2	V
$V_{\mathrm{F}}$	Diode Forward Voltage		$T_{i} = 150^{\circ}C$		1.5		·
$t_{rr}$	Reverse Recovery Time  Reverse Recovery Charge	$I_F = 100A$ $V_R = 300V$	$T_j = 25^{\circ}C$		100		ns
·rr			$T_j = 150$ °C		150		113
Qrr			$T_j = 25^{\circ}C$		5.1		μС
Q <sub>rr</sub>	Reverse Recovery Charge		$T_{j} = 150^{\circ}C$		10.7		μС
$E_{r}$	Davarra Dagayary Engray	•	$T_j = 25^{\circ}C$		1.2		mJ
$\mathbf{L}_{\mathrm{r}}$	Reverse Recovery Energy		$T_{\rm j} = 150^{\circ}{\rm C}$		2.4		1113

Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
$R_{thJC}$	Junction to Case Thermal Resistance  Per IGB	Per IGBT			0.44	°C/W	
	Punction to Case Thermal Resistance		Per Diode			0.77	C/ W
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
$T_{J}$	Operating junction temperature range			-40		175	
$T_{STG}$	Storage Temperature Range			-40		125	°C
$T_{\rm C}$	Operating Case Temperature					100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight					110	g

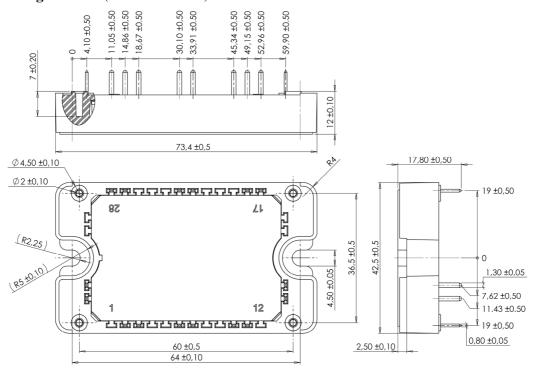
**Temperature sensor NTC** 

remper	ature sensor ivi				
Symbol	Characteristic	Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		22		kΩ
$\Delta R_{25}/R_{25}$	Resistance tolerance			5	%
$\Delta \mathrm{B/B}$	Beta tolerance			3	70
B <sub>25/100</sub>	$T_{25} = 298.16 \text{ K}$		3980		K

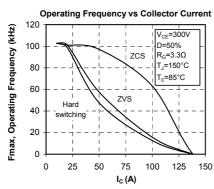
$$R_{T} = \frac{R_{25}}{\exp \left[ B_{25/100} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature} \quad R_{T}: \text{ Thermistor value at T}$$

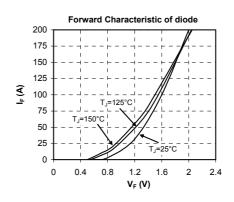


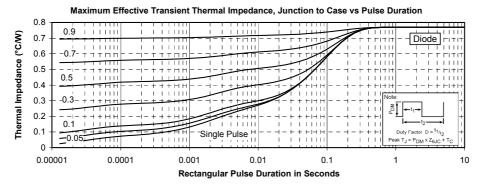
### SP3F Package outline (dimensions in mm)



### **Typical Performance Curve**

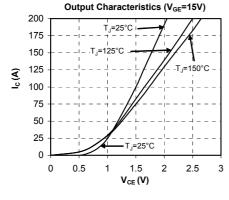


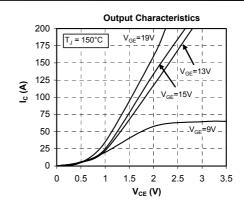


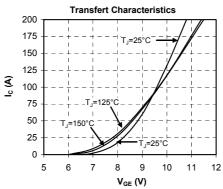


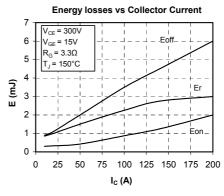
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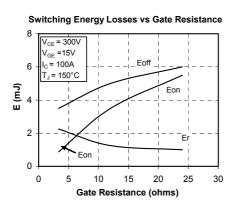


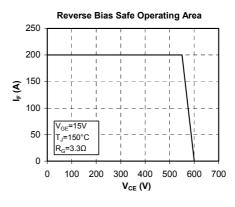


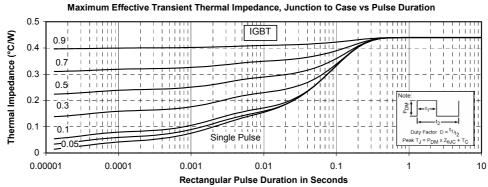












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